# imall

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Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







30V COMPLEMENTARY ENHANCEMENT MODE MOSFET H-BRIDGE

#### **Product Summary**

Device	V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> max	I <sub>D</sub> max T <sub>A</sub> = +25°C
	<u> </u>	6.0	
N-Channel	30V	40mΩ @ V <sub>GS</sub> = 4.5V	4.6
	0.01/	50mΩ @ V <sub>GS</sub> = -10V	-4.2
P-Channel	Channel -30V	80mΩ @ V <sub>GS</sub> = -4.5V	-3.2

#### **Description and Applications**

This new generation complementary MOSFET H-Bridge features 2 N and 2 P channel in an SOIC package. Qualified to AECQ101 the H bridge is ideally suited to driving :

- Solenoids
- DC Motors
- Audio Outputs

#### Features

- 2 x N + 2 x P channels in a SOIC package
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability
- PPAP Capable (Note 4)

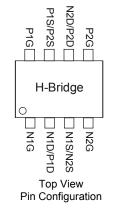
#### Mechanical Data

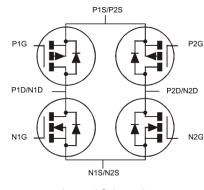
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See diagram
- Terminals: Finish Matte Tin annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 3
- Weight: 0.074 grams (approximate)



SO-8

Top View





Internal Schematic

#### Ordering Information (Note 5)

k			
Part Number	Compliance	Case	Packaging
DMHC3025LSDQ-13	Automotive	SO-8	2,500/Tape & Reel

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

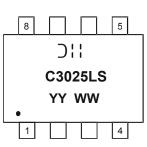
3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. Automotive products are AEC-Q101 qualified and are PPAP capable. Automotive, AEC-Q101 and standard products are electrically and thermally the same, except where specified. For more information, please refer to http://www.diodes.com/quality/product\_grade\_definitions/.

5. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

### **Marking Information**

Notes:



>:' = Manufacturer's Marking C3025LS = Product Type Marking Code YYWW = Date Code Marking YY = Year (ex: 09 = 2009) WW = Week (01 - 53)

See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.



#### **Thermal Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units	
Total Power Dissipation (Note 6)	PD	1.5	W	
Thermal Decistance, Junction to Ambient (Note 6)	Steady State	Р	83	
Thermal Resistance, Junction to Ambient (Note 6)	t < 10s	$R_{\thetaJA}$	50	°C/W
Thermal Resistance, Junction to Case	$R_{\theta JC}$	14.5		
Operating and Storage Temperature Range	T <sub>J,</sub> T <sub>STG</sub>	-55 to 150	°C	

#### Maximum Ratings N-CHANNEL (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V <sub>DSS</sub>	30	V		
Gate-Source Voltage			V <sub>GSS</sub>	±20	V
Continuous Drain Current (Note 6) )/ = 10)/	Steady State	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	ID	6.0 4.8	A
Continuous Drain Current (Note 6) $V_{GS}$ = 10V	t < 10s	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	ID	7.8 6.1	А
Continuous Drain Current (Note C) / - 4 5)/	Steady State	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	ID	4.6 3.6	A
Continuous Drain Current (Note 6) $V_{GS}$ = 4.5V	t < 10s	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	ID	6.1 4.8	A
Maximum Continuous Body Diode Forward Current (Note 5)			I <sub>S</sub>	2.5	A
Pulsed Drain Current (10µs pulse, duty cycle = 1%)			I <sub>DM</sub>	60	А

# Maximum Ratings P-CHANNEL (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units			
Drain-Source Voltage	V <sub>DSS</sub>	30	V			
Gate-Source Voltage			V <sub>GSS</sub>	±20	V	
	Steady State	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	ID	-4.2 -3.3	A	
Continuous Drain Current (Note 6) V <sub>GS</sub> = -10V	t < 10s	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	ID	-5.4 -4.3	A	
	Steady State	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	ID	-3.2 -2.5	A	
Continuous Drain Current (Note 6) V <sub>GS</sub> = -4.5V	t < 10s	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	ID	-4.3 -3.3	A	
Maximum Continuous Body Diode Forward Current	ls	-2.5	А			
Pulsed Drain Current (10µs pulse, duty cycle = 1%)			I <sub>DM</sub>	-30	А	

Note: 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.



Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	_		V	$V_{GS} = 0V, I_D = 250 \mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		—	0.5	μA	$V_{DS} = 30V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>		—	±1	μA	$V_{GS}$ = ±20V, $V_{DS}$ = 0V	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	1	_	2	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
Static Drain-Source On-Resistance	Deserver		19	25	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 5A	
	R <sub>DS (ON)</sub>		26	40	11122	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 4A	
Forward Transfer Admittance	Y <sub>fs</sub>	_	4	_	S	V <sub>DS</sub> = 5V, I <sub>D</sub> = 5A	
Diode Forward Voltage	V <sub>SD</sub>	—	0.70	1.2	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = 1.7A	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	Ciss		590	—	pF	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V, f = 1MHz	
Output Capacitance	C <sub>oss</sub>		122				
Reverse Transfer Capacitance	Crss	_	58	_			
Gate resistance	Rg	—	1.5	_	Ω	$V_{DS}$ = 0V, $V_{GS}$ = 0V, f = 1MHz	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qq	_	5.4	—			
Total Gate Charge (V <sub>GS</sub> = 10V)	Qq	_	11.7	_		V <sub>DS</sub> = 15V, I <sub>D</sub> = 7.8A	
Gate-Source Charge	Q <sub>gs</sub>		1.8		nC		
Gate-Drain Charge	Q <sub>qd</sub>	_	2.1	_			
Turn-On Delay Time	t <sub>D(on)</sub>		11.2	_			
Turn-On Rise Time	tr		15			V <sub>DD</sub> = 15V, V <sub>GS</sub> = 4.5V,	
Turn-Off Delay Time	t <sub>D(off)</sub>		17.5	_	ns	$R_L = 2.4\Omega$ , $R_G = 1\Omega$ ,	
Turn-Off Fall Time	t <sub>f</sub>	_	8.7	_		, - ,	
Reverse Recovery Time	trr	_	18.3	_	ns		
Reverse Recovery Charge	Q <sub>rr</sub>	_	12	_	nC	– I <sub>F</sub> = 12A, di/dt = 500A/μs	

#### Electrical Characteristics N-CHANNEL (@T<sub>A</sub> = +25°C, unless otherwise specified.)

# Electrical Characteristics P-CHANNEL (@T<sub>A</sub> = +25°C, unless otherwise specified.)

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Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)	1					1
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-30		—	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = -250µA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	—	_	-0.5	μA	$V_{DS} = -30V, V_{GS} = 0V$
Gate-Source Leakage	I <sub>GSS</sub>		_	±1	μA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	-1		-2	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
Static Drain-Source On-Resistance		—	43	50	mΩ	V <sub>GS</sub> = -10V, I <sub>D</sub> = -5A
	RDS (ON)		68	80	11152	$V_{GS}$ = -4.5V, $I_{D}$ = -4A
Forward Transfer Admittance	Y <sub>fs</sub>	_	3.5	_	S	$V_{DS}$ = -5V, $I_{D}$ = -5A
Diode Forward Voltage	V <sub>SD</sub>	—	-0.7	-1.2	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = -1.7A
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	Ciss		631	—	pF	
Output Capacitance	Coss	_	137	—	pF	−V <sub>DS</sub> = -15V, V <sub>GS</sub> = 0V, −f = 1MHz
Reverse Transfer Capacitance	C <sub>rss</sub>	_	70	—	pF	
Gate resistance	Rg		10.8	-	Ω	$V_{DS}$ = 0V, $V_{GS}$ = 0V, f = 1MHz
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg	_	5.5	—	nC	
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	—	11.4	-	nC	VDS = -15V. ID = -6A
Gate-Source Charge	Q <sub>gs</sub>		1.8	-	nC	$v_{\rm DS} = -15v, I_{\rm D} = -6A$
Gate-Drain Charge	Q <sub>gd</sub>	_	2.4	—	nC	
Turn-On Delay Time	t <sub>D(on)</sub>		7.5	-	ns	
Turn-On Rise Time	tr	_	4.9	—	ns	V <sub>DD</sub> = -15V, V <sub>GS</sub> = -10V,
Turn-Off Delay Time	t <sub>D(off)</sub>	—	28.2	—	ns	$R_{G} = 6\Omega, I_{D} = -1A$
Turn-Off Fall Time	t <sub>f</sub>		13.5	—	ns	
Reverse Recovery Time	t <sub>rr</sub>		15.1	—	ns	
Reverse Recovery Charge	Q <sub>rr</sub>	—	15.3	—	nC	- I <sub>F</sub> = 12A, di/dt = 500A/μs

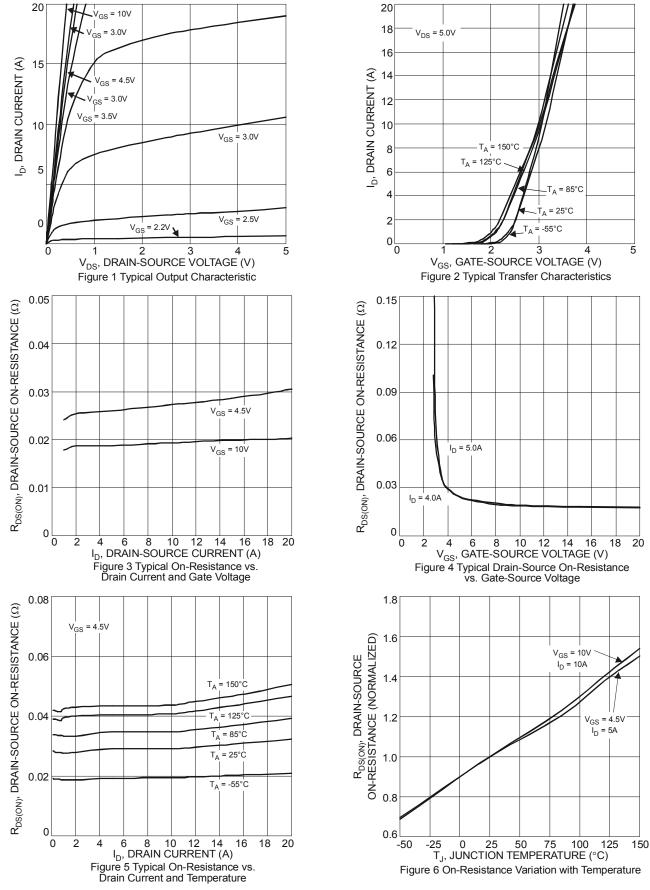
 Notes:
 7. Short duration pulse test used to minimize self-heating effect.

 8. Guaranteed by design. Not subject to product testing.



### DMHC3025LSDQ

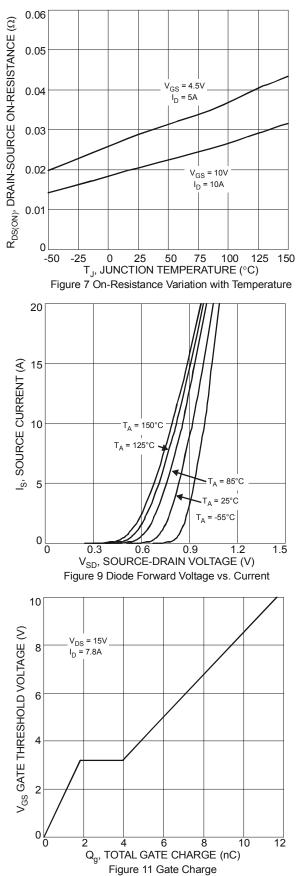




DMHC3025LSDQ Document number: DS37220 Rev. 1 - 2







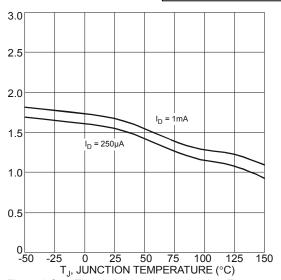
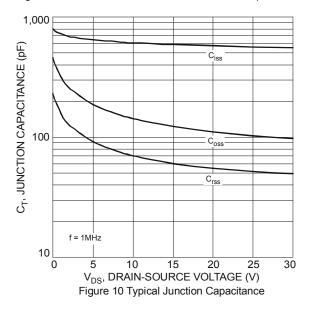
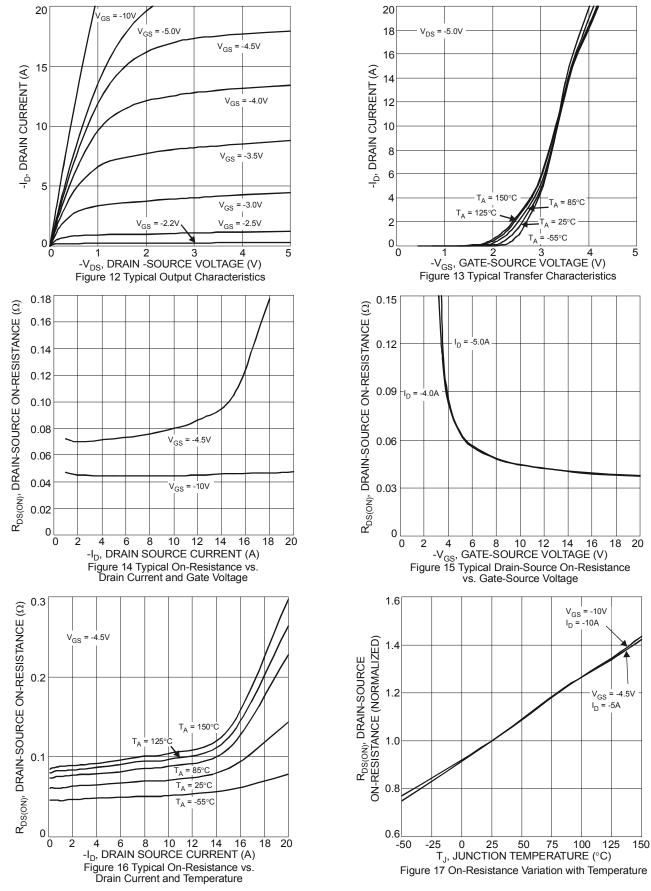


Figure 8 Gate Threshold Variation vs. Ambient Temperature

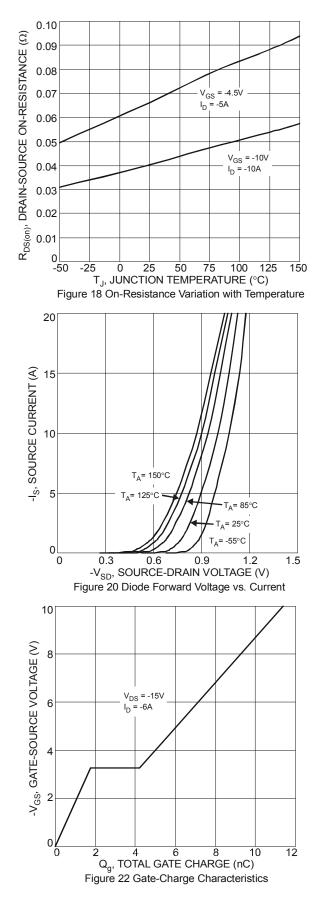


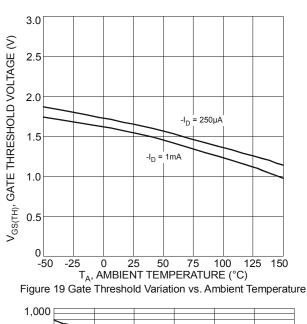


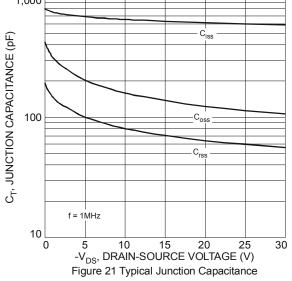








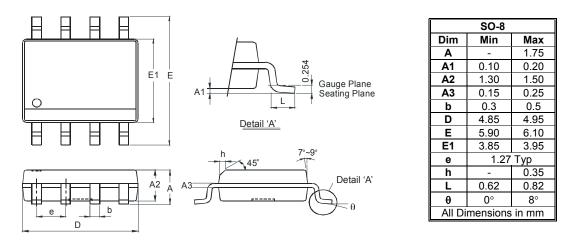






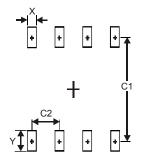
#### **Package Outline Dimensions**

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



#### Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Х	0.60
Y	1.55
C1	5.4
C2	1.27



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